



**ALPHA & OMEGA**  
SEMICONDUCTOR



**AO4826**

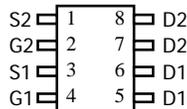
**Dual N-Channel Enhancement Mode Field Effect Transistor**

**General Description**

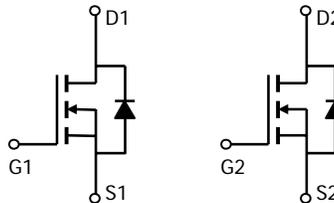
The AO4826 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. *Standard Product AO4826 is Pb-free (meets ROHS & Sony 259 specifications).*

**Features**

$V_{DS}$  (V) = 60V  
 $I_D$  = 6.3A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)} < 25m\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)} < 30m\Omega$  ( $V_{GS}$  = 4.5V)



**SOIC-8**



**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                              | Symbol                 | Maximum    | Units            |
|--|------------------------|------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$               | 60         | V                |
| Gate-Source Voltage                    | $V_{GS}$               | $\pm 20$   | V                |
| Continuous Drain Current <sup>A</sup>  | $T_A=25^\circ\text{C}$ | 6.3        | A                |
|  | $T_A=70^\circ\text{C}$ | 5          |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$               | 40         |                  |
| Power Dissipation                      | $T_A=25^\circ\text{C}$ | 2          | W                |
|  | $T_A=70^\circ\text{C}$ | 1.28       |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$         | -55 to 150 | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ          | Max  | Units              |
|--|-----------------|--------------|------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 50           | 62.5 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 73   |                    |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 31           | 40   | $^\circ\text{C/W}$ |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                              | Conditions  | Min | Typ      | Max      | Units |
|-----------------------------|--|---|-----|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |  |   |     |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage         | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 60  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current        | V <sub>DS</sub> =48V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |          | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current              | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V   |     |          | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                 | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1   | 2.1      | 3        | V     |
| I <sub>D(ON)</sub>          | On state drain current                 | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V   | 40  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance      | V <sub>GS</sub> =10V, I <sub>D</sub> =6.3A<br>T <sub>J</sub> =125°C                       |     | 20<br>34 | 25<br>42 | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =5.7A   |     | 22       | 30       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance               | V <sub>DS</sub> =5V, I <sub>D</sub> =6.3A   |     | 27       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                  | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.74     | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current  |   |     |          | 3        | A     |
| I <sub>SM</sub>             | Pulsed Body Diode Current <sup>B</sup> |   |     |          | 40       | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |   |     |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                      | V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz   |     | 1920     | 2300     | pF    |
| C <sub>oss</sub>            | Output Capacitance                     |   |     | 155      |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance           |   |     | 116      |          | pF    |
| R <sub>g</sub>              | Gate resistance                        | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |     | 0.65     | 0.8      | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |   |     |          |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                      | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =6.3A                          |     | 47.6     | 58       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                      |   |     | 24.2     | 30       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                     |   |     | 6        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                      |   |     | 14.4     |          | nC    |
| t <sub>D(on)</sub>          | Turn-On Delay Time                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, R <sub>L</sub> =4.7Ω,<br>R <sub>GEN</sub> =3Ω |     | 7.6      |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                      |   |     | 5        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off Delay Time                    |   |     | 28.9     |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                     |   |     | 5.5      |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time       | I <sub>F</sub> =6.3A, dI/dt=100A/μs   |     | 33.2     | 40       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge     | I <sub>F</sub> =6.3A, dI/dt=100A/μs   |     | 43       |          | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

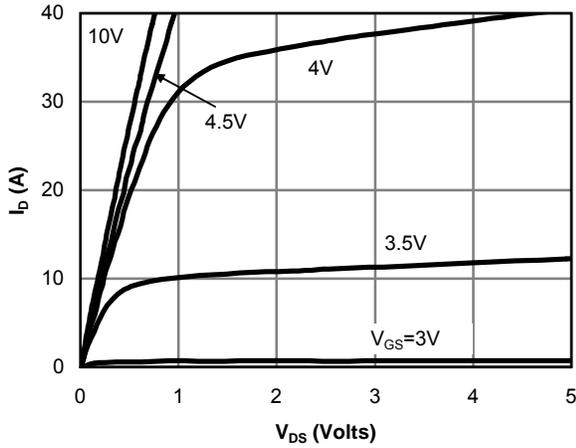


Fig 1: On-Region Characteristics

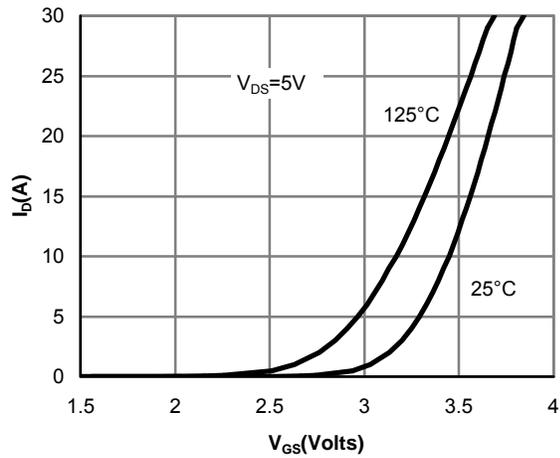


Figure 2: Transfer Characteristics

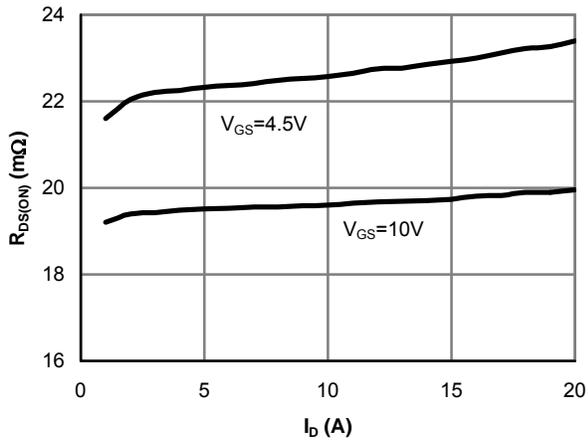


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

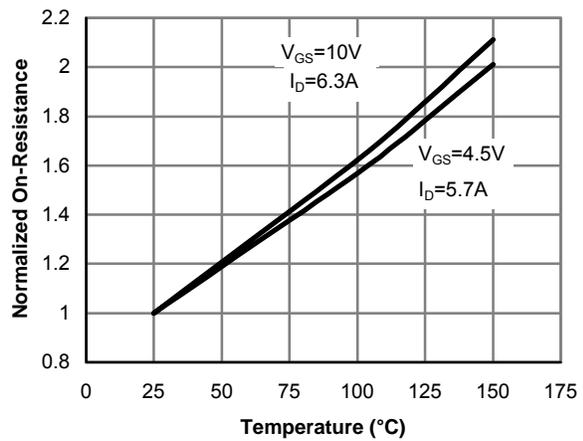


Figure 4: On-Resistance vs. Junction Temperature

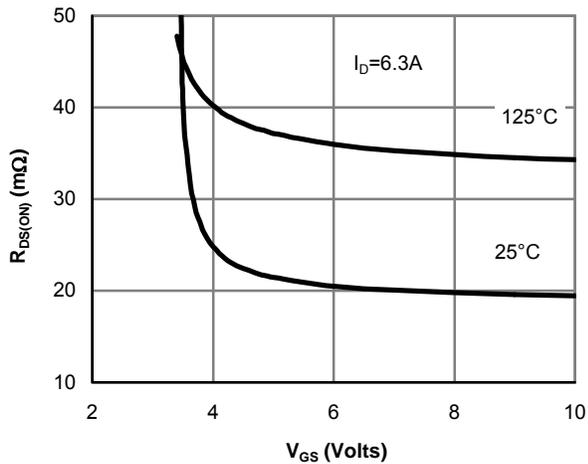


Figure 5: On-Resistance vs. Gate-Source Voltage

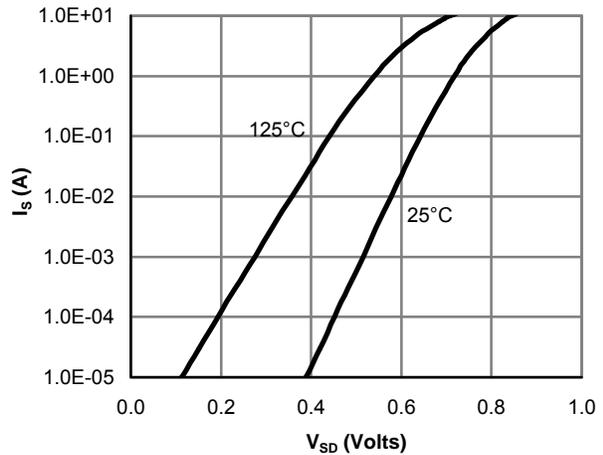


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

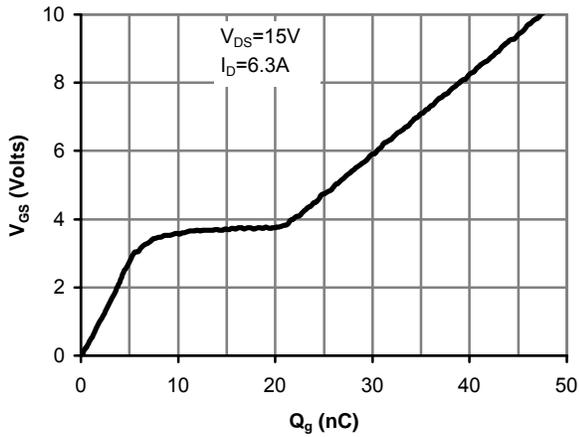


Figure 7: Gate-Charge Characteristics

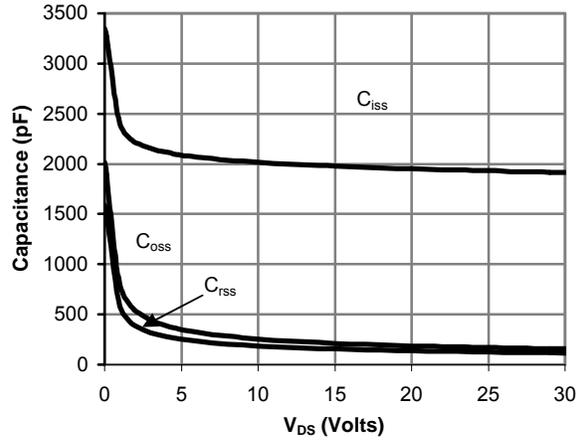


Figure 8: Capacitance Characteristics

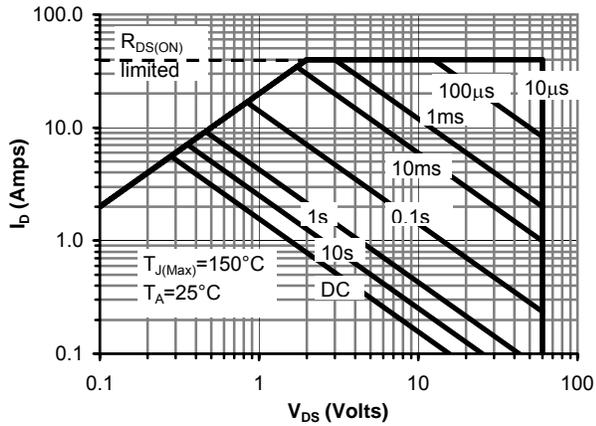


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

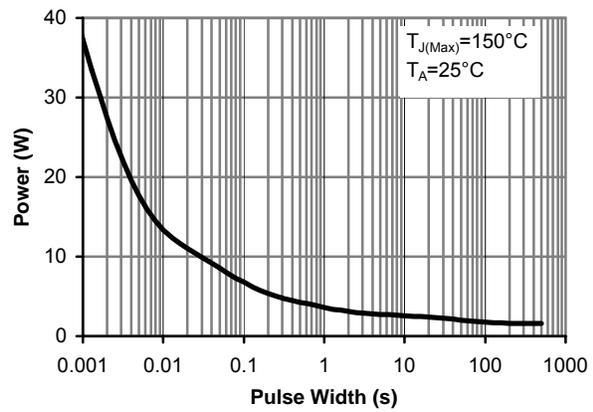


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

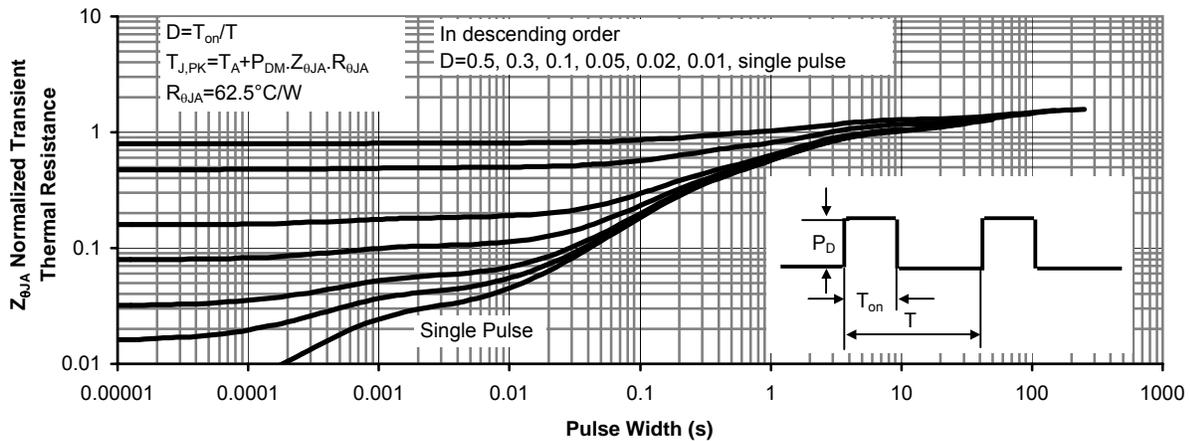


Figure 11: Normalized Maximum Transient Thermal Impedance